Search Notes



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Examiner Heyman, John Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
349	110, 129 and text search	07/07/2007	JSH
349	110, 122, 139, 155	04/13/2008	JSH

SEARCH NOTES

Search Notes	Date	Examiner
Consult Primary Examiner Andrew Schechter	07/07/2007	JSH

INTERFERENCE SEARCH

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